Field Effect Transistor

Silicon N Channel MOS Type (t-MOS IV)

High Speed, High Current Switching Applications

Features

- Low Drain-Source ON Resistance
- R_{DS(ON)} = 0.10Ω (Typ.) High Forward Transfer Admittance
 - $|Y_{fs}| = 3.0S$ (Typ.)
- Low Leakage Current
 - $I_{DSS} = 100 \mu A \text{ (Max.) } @ V_{DS} = 60 \text{ V}$
- Enhancement-Mode
 - $V_{th} = 2.0 \sim 4.0 V @ V_{DS} = 10 V$, $I_{D} = 1 mA$

Absolute Maximum Ratings (Ta = 25C)

CHARACTERISTIC Drain-Source Voltage Drain-Gate Voltage ($R_{GS} = 20k\Omega$) Gate-Source Voltage		SYMBOL	RATING	UNIT	
		V _{DSS} V _{DGR} V _{GSS}	60		
			60	٧	
			±20	٧	
Drain Current	DC	I _D	5	Α	
	Pulse	I _{DP}	20		
Drain Power Dissipation (Tc = 25°C)		PD	20	W	
Channel Temperature		T _{ch}	150	င့	
Storage Temperature		T _{stg}	-55 ~ 150	°C	

Thermal Characteristics

CHARACTERISTIC	SYMBOL	MAX.	UNIT
Thermal Resistance, Channel to Case	R _{th(ch-c)}	6.25	°C/W
Thermal Resistance, Channel to Ambient	R _{th(ch-a)}	125	°C/W

This transister is an electrostatic sensitive device. Please handle with caution.

Unit in mm 6.8 MAX 0.6MAX 0.6MAX GATE 2. DRAIN (HEAT SINK) 3. SOURCE

SC-64

2-7B1B

Weight: 0.36g

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Electrical Characteristics (Ta = 25C)

CHARAC	CTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		I _{GSS}	$V_{GS} = \pm 16V, V_{DS} = 0V$	-	-	±10	μA
Drain Cut-off Current		IDSS	$V_{DS} = 60V, V_{GS} = 0V$	-	-	100	μA
Drain-Source Brea	akdown Voltage	V _{(BR) DSS}	$I_D = 10$ mA, $V_{GS} = 0$ V	60		-	٧
Gate Threshold Vo	oltage	V _{th}	V _{DS} = 10V, I _D = 1mA	2.0		4.0	٧
Drain-Source ON	Resistance	R _{DS (ON)}	V _{GS} = 10V, I _D = 2.5A	-	0.10	0.14	Ω
Forward Transfer	Admittance	lY _{fs} i	V _{DS} = 10V, I _D = 2.5A	1.8	3.0		S
Input Capacitance Reverse Transfer Capacitance		C _{iss}	V _{DS} = 10V, V _{GS} = 0V, f = 1MH7	-	400	700	pF
		C _{rss}		-	120	240	
Output Capacitano	Xe Se	Coss	1-114112		300	500	
Switching Time	Rise Time	tr		-	25	50	
	Turn-on Time	t _{on}	I _D = 2.5 A	-	65	130	ns
	Fall Time	t _f	TUOV T	-	25	50	110
Turn-off Time	t _{off}	$V_{GS} = \begin{cases} 10V & R_{L} = 10\Omega \\ 0 & V_{DD} = 30V \end{cases}$ $V_{IN}: t_{f} \cdot t_{f} < 5ns$ $Duty \le 1\%, t_{w} = 10\mu s$	-	70	140		
Total Gate Charge (Gate-Source Plus Gate-Drain)		Qg	V _{DD} = 48V, V _{GS} = -10V,	-	15	30	
Gate-Source Charge		Q _{gs}	I _D = 5A	-	7	-	nC
Gate-Drain ("Mill	er") Charge	Q _{gd}		-	8		

Source-Drain Diode Ratings and Characteristics (Ta = 250)

CHARACTERISTICS	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Continuous Drain Reverse Current	I _{DR}	-	T - 1	_	5	Α
Pulse Drain Reverse Current	I _{DRP}	-	- 1	-	20	Α
Diode Forward Voltage	V _{DSF}	$I_{DR} = 5A$, $V_{GS} = 0V$	-	-	-1.5	٧

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